

International workshop on non-invasive beam profile monitors for hadron machines and its related techniques: 3rd IPM workshop

Contribution ID: 10

Type: **not specified**

Non-destructive 2-D beam profile monitor using gas sheet in J-PARC

Wednesday, 19 September 2018 10:30 (30 minutes)

Presenter: Dr KAMIYA, Junichiro (JAEA)

Session Classification: Beam Induced Fluorescence Monitors and the other monitors